

**SIE 406/506 QUALITY ENGINEERING - Spring 2019**  
**(Tuesday and Thursday 11:00am– 12:15pm, Aero & Mech Engr S212)**

**Instructor:** Jian Liu  
 Office: ENGR 221  
 Phone: 520-621-6548  
 Hours: Tue. 12:30 – 1:30PM and  
 Or by appointment

**TA:** Bijoy Chowdhury  
 Office: ENGR 258  
 Hours: Mon 2:00 – 3:00 pm  
 Wed 11:00 am – 12:00 pm  
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**Online Office Hours:**  
 Tue 8:00-9:00 pm  
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 Mon/Wed 6:00-7:00 pm  
 Email: [bijoy@email.arizona.edu](mailto:bijoy@email.arizona.edu)

**Skype account for online student office hours:** [530siesie@gmail.com](mailto:530siesie@gmail.com)

**Text:** “Introduction to Statistical Quality Control”, D. Montgomery, 7<sup>th</sup> edition.

**Website:** <http://d2l.arizona.edu/>

**Course videos:** D2L-> UA Tools -> Panopto

**Temporary Lecture Schedule:**

| <b>Lecture</b> | <b>Dates</b> | <b>Topics</b>                               | <b>References</b> |
|----------------|--------------|---|-------------------|
| 1              | 01/10        | Course overview + Introduction              | Ch 1              |
| 2              | 01/15        | Modeling Process Quality (MPQ)              | Ch 2              |
| 3              | 01/17        | MPQ + Inferences About Quality              | Ch 2/3            |
| 4              | 01/22        | Inferences About Quality                    | Ch 3              |
| 5              | 01/24        | Inferences About Quality                    | Ch 3              |
| 6              | 01/29        | Inferences About Quality                    | Ch 3              |
| 7              | 01/31        | Methods and Philosophies                    | Ch 4              |
| 8              | 02/05        | Methods and Philosophies                    | Ch 4              |
| 9              | 02/07        | Quality Control Philosophies & Applications | Ch 4              |
| 10             | 02/12        | Charting Variables                          | Ch 5              |
| 11             | 02/14        | Charting Variables                          | Ch 5              |
| 12             | 02/19        | Charting Variables                          | Ch 5              |
| 13             | 02/21        | Implementing Charts + Charting Attribute    | Ch 5+6            |
| 14             | 02/26        | Review Session for Exam I                   |                   |
| 15             | <b>02/28</b> | <b>Exam I (in class)</b>                    |                   |
|                | 03/05        | Spring Recess                               |                   |
|                | 03/07        | Spring Recess                               |                   |
| 16             | 03/12        | Group project discussion and Exam I Review  |                   |
| 17             | 03/14        | CUSUM                                       | Ch 8              |
| 18             | 03/19        | CUSUM + EWMA + MA                           | Ch 8              |
| 19             | 03/21        | Short Production Runs                       | Ch9-1             |
| 20             | 03/26        | SPC with Autocorrelated Data                | Ch9-4             |
| 21             | 03/28        | Process Capability                          | Ch 7              |
| 22             | 04/02        | Project Preparation                         |                   |
| 23             | 04/04        | Gage R&R                                    | Ch 7              |
| 24             | 04/09        | Specification/Tolerances                    | Ch 7              |
| 25             | 04/11        | Acceptance Sampling                         | Ch 14             |

|           |              |                                     |       |
|-----------|--------------|-------------------------------------|-------|
|           | 04/16        | Acceptance Sampling                 | Ch 14 |
|           | 04/18        | Project Preparation/Presentations   |       |
|           | 04/23        | Project Preparation/Presentations   |       |
|           | 04/25        | Project Preparation/Presentations   |       |
| 26        | 04/30        | Review Session for Exam II          |       |
| 27        | 05/01        | Project Report Due (12:00 PM)       |       |
| <b>28</b> | <b>05/07</b> | <b>Exam II (10:30 AM– 12:00 PM)</b> |       |

*The above topics and schedule are subject to change. Revisions in the syllabus may occur as the semester progresses.*

**Homework:**

The homework will be assigned on Thursdays and due on the following Thursday, *before the end of the class*. NO late submission is allowed unless it is requested and approved by the instructor in advance (e-mail or phone-call received *before* the date the assignment is due). You are encouraged to discuss homework problems with fellow students. But your final product should be based on your own understanding. Copying other's work is not acceptable.

**Examinations:**

Exam I: **February 28**, Thursday, in class

Exam II: **May 07**, Tuesday, 10:30 AM – 12:00PM.

Makeup examinations **MUST** be requested at least one week prior to the date the exam is held. In case of medical or other personal/family emergencies, a formal excuse (doctor’s note, etc.) is required.

**Project:**

Project requirements and guidance will be posted on **February 14, 2019**. Teamwork, individual contribution, group presentation and group report will be required and evaluated.

|                 |          |     |
|-----------------|----------|-----|
| <b>Grading:</b> | Homework | 15% |
|                 | Exam I   | 30% |
|                 | Exam II  | 35% |
|                 | Project  | 20% |

*There is no extra credit for any student*

**Course Outcomes:**

- 1 Develop a control chart for monitoring continuous and discrete quality characteristics.
- 2 Design acceptance-sampling plans.
- 3 Assess statistical process capability.
- 4 Implement CUSUM and EWMA charts.
- 5 Establish specific plan for short production run.
- 6 Assess product specifications and tolerances.